# INFORMATION DISCLOSURE CITATION

*(Use several sheets if necessary)*

MAR 15 2004

| Docket Number (Optional) | Application Number |
|---|---|
| HITACHI-[redacted]8 | 09/602,964 |
| **Applicant(s)** | #7 |
| MAZAWA, et al. | |
| **Filing Date** | **Group Art Unit** |
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## U.S. PATENT DOCUMENTS

| *EXAMINER INITIAL | REF | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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## FOREIGN PATENT DOCUMENTS

| | REF | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | Translation YES | Translation NO |
|---|---|---|---|---|---|---|---|---|
| IQ | AA | JP10-145864 | 5/29/1998 | Japan*abstract enclosed | | | | ✓ |
| IQ | AB | JP10-276473 | 10/13/1998 | Japan*abstract enclosed | | | | ✓ |
| IQ | AC | JP10-304430 | 11/13/1998 | Japan*abstract enclosed | | | | ✓ |
| IQ | AD | JP10-327474 | 12/8/1998 | Japan*abstract enclosed | | | | ✓ |
| IQ | AE | JP10-032882 | 2/3/1998 | Japan*abstract enclosed | | | | ✓ |

## OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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| EXAMINER | DATE CONSIDERED |
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| [signature] | 05/28/04 |

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# INFORMATION DISCLOSURE CITATION

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MAR 15 2004
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| ATTY DOCKET NO. | SERIAL NO. |
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| HITACHI [redacted]8 | 09/602,964 |
| APPLICANT(S) | |
| MAZAWA, et al. | |
| FILING DATE | GROUP |
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## U.S. PATENT DOCUMENTS

| *EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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## FOREIGN PATENT DOCUMENTS

| | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION YES | TRANSLATION NO |
|---|---|---|---|---|---|---|---|---|
| IQ | AF | JP11-008885 | 1/12/1999 | Japan*abstract enclosed | | | | ✓ |
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## OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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| [signature] | 05/28/04 |

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